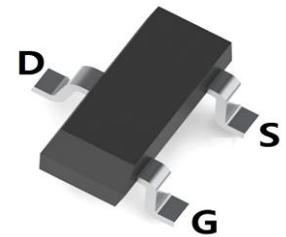
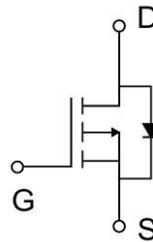


**P-Channel Enhancement Mode MOSFET -20V/-5.0A**

Parameter	Value	Unit
$V_{DS}$	-20	V
$R_{DS(on)}$	29	m $\Omega$
$I_D$	-5.0	A



SOT-23

**Features**

- Super Low Gate Charge
- Green Device Available
- Excellent  $CdV/dt$  effect decline
- Advanced high cell density Trench technology

**Absolute Maximum Ratings**( $T_a=25^{\circ}C$  unless otherwise noted)

Symbol	Parameter	Rating		Units
		10s	Steady State	
$V_{DS}$	Drain-Source Voltage	-20		V
$V_{GS}$	Gate-Source Voltage	$\pm 10$		V
$I_{D@TA=25^{\circ}C}$	Continuous Drain Current, $V_{GS} @ -4.5V^1$	-5.	-4.	A
$I_{D@TA=70^{\circ}C}$	Continuous Drain Current, $V_{GS} @ -4.5V^1$	-4.	-3.7	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	-18		A
$P_D@TA=25^{\circ}C$	Total Power Dissipation <sup>3</sup>	1.32	1	W
$T_{STG}$	Storage Temperature Range	-55 to 150		$^{\circ}C$
$T_J$	Operating Junction Temperature Range	-55 to 150		$^{\circ}C$

**Thermal Data**

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient <sup>1</sup>	-	125	$^{\circ}C/W$
$R_{\theta JA}$	Thermal Resistance Junction-Ambient <sup>1</sup> ( $t \leq 10s$ )	-	95	$^{\circ}C/W$
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	-	80	$^{\circ}C/W$

**Electrical Characteristics**( $T_a=25^{\circ}C$  unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
<b>Off Characteristic</b>						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-20	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-20V, V_{GS}=0V,$	-	-	-1	$\mu A$

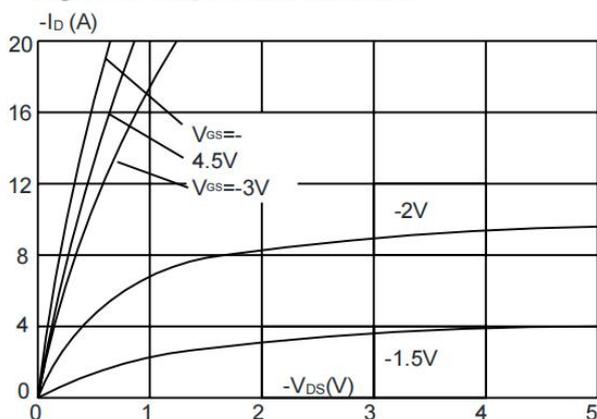
$I_{GSS}$	Gate to Body Leakage Current	$V_{DS}=0V, V_{GS}=\pm 10V$	-	-	$\pm 10$	$\mu A$
<b>On Characteristics</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.4	-0.7	-1.0	V
$R_{DS(on)}$	Static Drain-Source on-Resistance note2	$V_{GS}=-4.5V, I_D=-4A$	-	29	40	m $\Omega$
		$V_{GS}=-2.5V, I_D=-3A$	-	40	56	
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=-10V, V_{GS}=0V,$ $f=1.0MHz$	-	289	-	pF
$C_{oss}$	Output Capacitance		-	98	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	22	-	pF
$Q_g$	Total Gate Charge	$V_{DS}=-10V, I_D=-4.1A,$ $V_{GS}=-4.5V$	-	9	-	nC
$Q_{gs}$	Gate-Source Charge		-	1	-	nC
$Q_{gd}$	Gate-Drain("Miller") Charge		-	2.6	-	nC
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=-10V, R_G=1\Omega,$ $V_{GEN}=-4.5V, R_L=1.2\Omega$	-	12	-	ns
$t_r$	Turn-on Rise Time		-	35	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	30	-	ns
$t_f$	Turn-off Fall Time		-	10	-	ns
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain to Source Diode Forward Current		-	-	-4.1	A
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-16.4	A
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS}=0V, I_S=-4.1A$	-	-	-1.2	V

Note:

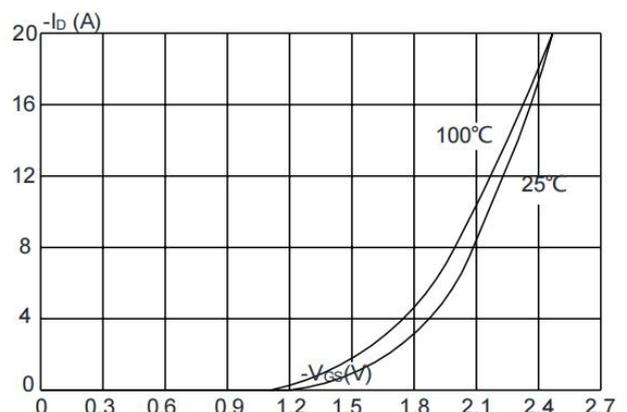
- 1.Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2.Pulse Test: pulse width  $\leq 300 \mu s$ , duty cycle  $\leq 2\%$ .

### Typical Characteristics

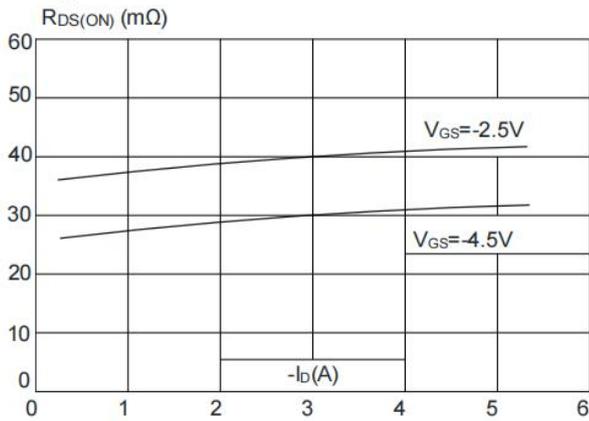
**Figure1:** Output Characteristics



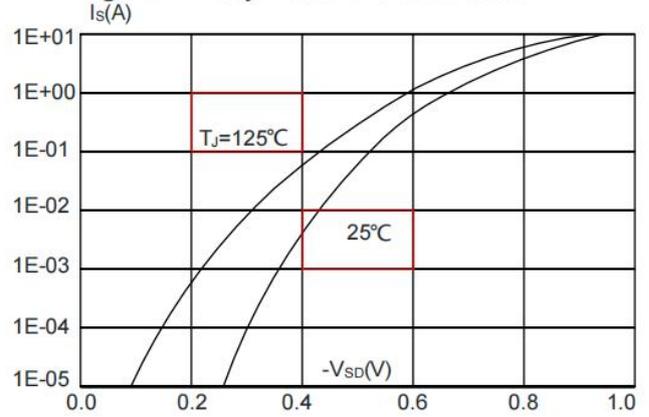
**Figure 2:** Typical Transfer Characteristics



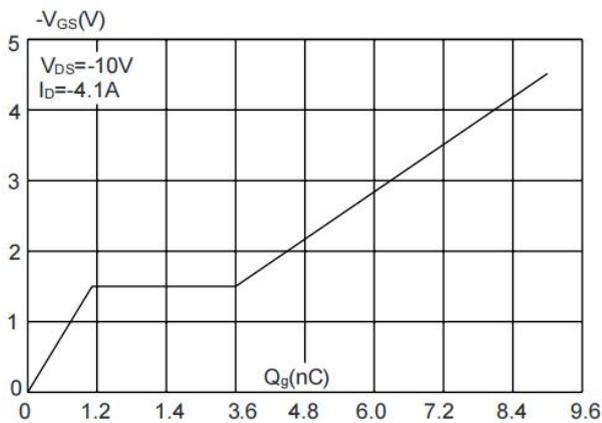
**Figure 3: On-resistance vs. Drain Current**



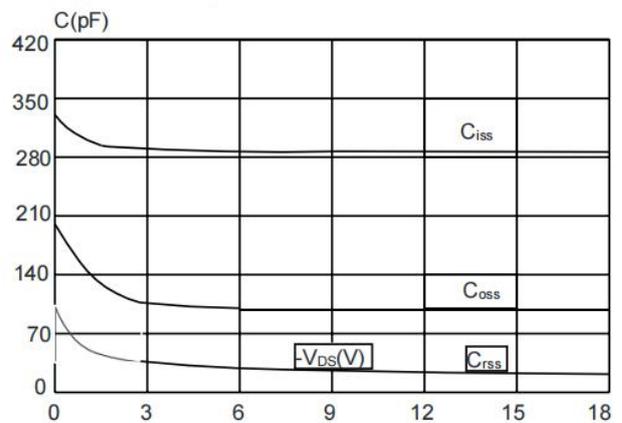
**Figure 4: Body Diode Characteristics**



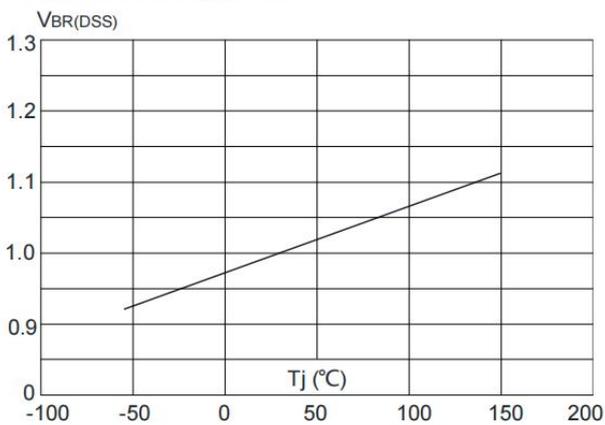
**Figure 5: Gate Charge Characteristics**



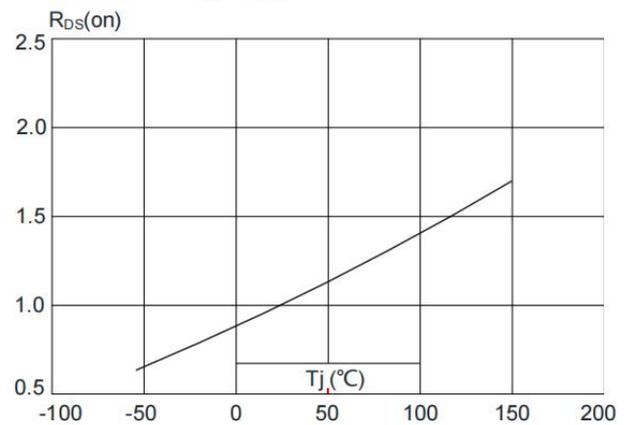
**Figure 6: Capacitance Characteristics**



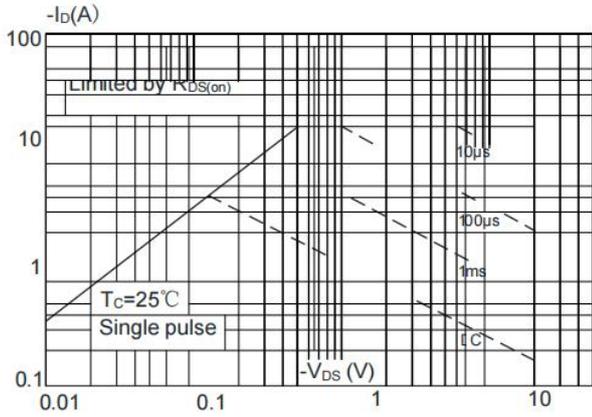
**Figure 7: Normalized Breakdown Voltage vs. Junction Temperature**



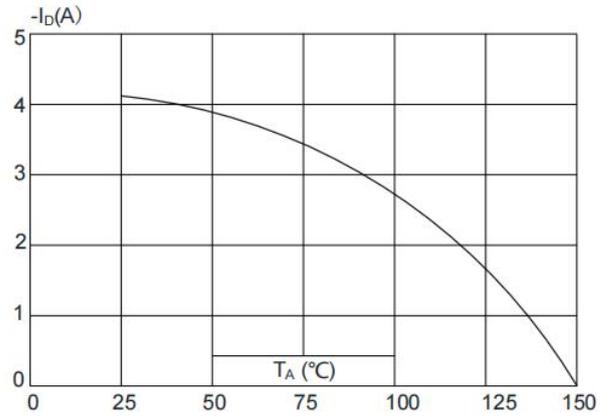
**Figure 8: Normalized on Resistance vs. Junction Temperature**



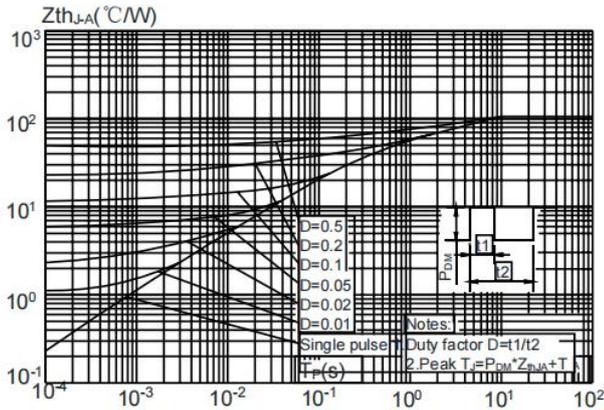
**Figure 9: Maximum Safe Operating Area**



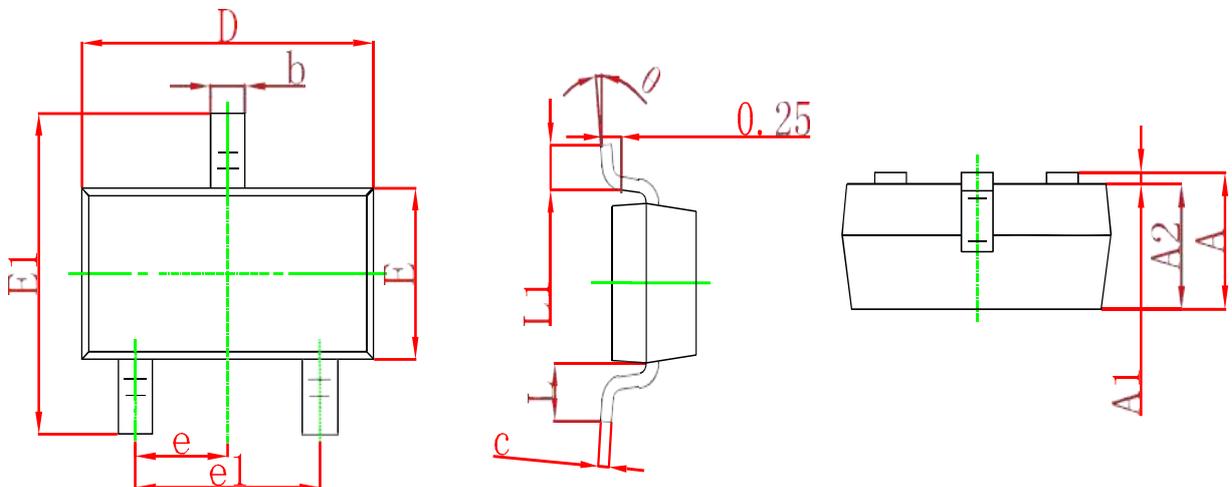
**Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature**



**Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient**

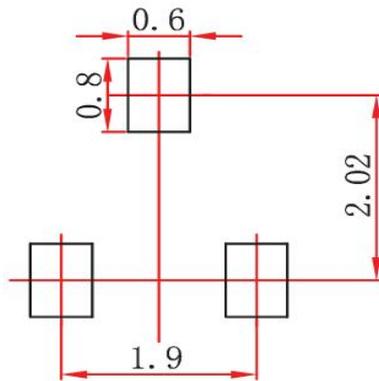


**Package Outline**



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP		0.037 TYP	
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022 REF	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

### SOT-23 Suggested Pad Layout



**Note:**

1. Controlling dimension: in millimeters
2. General tolerance:  $\pm 0.05\text{mm}$
3. The pad layout is for reference purposes only

### \*Important Usage Information and Disclaimer

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